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Application/Control No.	Applicant(s)/Patent under Reexamination
10/796,396	QUAN ET AL.
Examiner	Art Unit
Rita J. Desai	1625

SEARCHED				
Class	Subclass	Date	Examiner	
546	152	4/13/05	PO	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
546	152	1/6/05	Po.	
514	311	1	1	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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